Advance Information

Power MOSFET 100V, 2.8mΩ, 180A, N-Channel

Features

- Ultra Low On-Resistance
- Low Gate Charge
- High Speed Switching
- 100% Avalanche Tested
- Pb-Free, Halogen Free and RoHS Compliance

Specifications

Absolute Maximum Ratings at Ta = 25 °C

Parameter	Symbol	Value	Unit
Drain to Source Voltage	V _{DSS}	100	V
Gate to Source Voltage	V _{GSS}	±20	V
Drain Current (DC)	ID	180	А
Drain Current (DC) Limited by Package	IDL	100	А
Drain Current (Pulse) PW≤10μs, duty cycle≤1%	I _{DP}	600	A
Power Dissipation Tc=25°C	PD	200	W
Junction Temperature	Tj	175	°C
Storage Temperature	Tstg	-55 to +175	°C
Source Current (Body Diode)	IS	100	А
Avalanche Energy (Single Pulse) *1	E _{AS}	451	mJ
Lead Temperature for Soldering Purposes, 3mm from Case for 10 Seconds	ΤL	260	°C

Thermal Resistance Ratings

Parameter	Symbol	Value	Unit	
Junction to Case Steady State	$R_{\theta JC}$	0.75	°C/W	
Junction to Ambient *2	$R_{\theta JA}$	62.5		

Note : *1 VDD=48V, L=100 $\mu H,$ IAV=70A (Fig.1)

*2 Surface mounted on FR4 board using recommended footprint

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

ORDERING INFORMATION

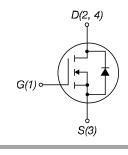
See detailed ordering and shipping information on page 6 of this data sheet.

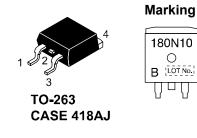


VDSS	R _{DS} (on) Max	^I D Max
100V	2.8 mΩ@15V	180A
	3.3 mΩ@10V	

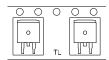
Electrical Connection







Packing Type:TL



Electrical	Characteristics at Ta = 25°C	
------------	-------------------------------------	--

Devenueter	O with all		Value			
Parameter	Symbol Conditions		min	typ	max	Unit
Drain to Source Breakdown Voltage	V(BR)DSS	ID=10mA, VGS=0V	100			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =100V, V _{GS} =0V			10	μA
Gate to Source Leakage Current	IGSS	V _{GS} =±20V, V _{DS} =0V			±200	nA
Gate Threshold Voltage	V _{GS} (th)	V _{DS} =10V, I _D =1mA	2		4	V
Forward Transconductance	9FS	V _{DS} =10V, I _D =50A		150		S
	R _{DS} (on)1	I _D =50A, V _{GS} =15V		2.3	2.8	mΩ
Static Drain to Source On-State Resistance	R _{DS} (on)2	ID=50A, VGS=10V		2.5	3.3	mΩ
Input Capacitance	Ciss			6,950		pF
Output Capacitance	Coss	V _{DS} =50V, f=1MHz		3,000		pF
Reverse Transfer Capacitance	Crss			15		pF
Turn-ON Delay Time	t _d (on)			95		ns
Rise Time	tr			320		ns
Turn-OFF Delay Time	t _d (off)	See Fig.2		185		ns
Fall Time	tf			130		ns
Total Gate Charge	Qg			95		nC
Gate to Source Charge	Qgs	V _{DS} =48V, V _{GS} =10V, I _D =100A		31		nC
Gate to Drain "Miller" Charge	Qgd	7		26		nC
Forward Diode Voltage	V _{SD}	IS=100A, VGS=0V		0.9	1.5	V
Reverse Recovery Time	trr	See Fig.3		150		ns
Reverse Recovery Charge	Q _{rr}	I _S =100A, V _{GS} =0V, di/dt=100A/μs		580		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Fig.1 Unclamped Inductive Switching Test Circuit

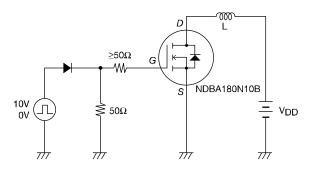


Fig.3 Reverse Recovery Time Test Circuit

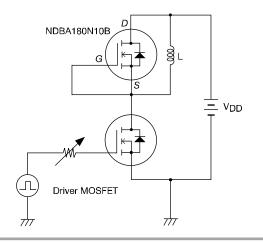
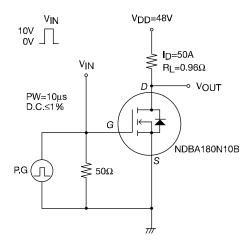
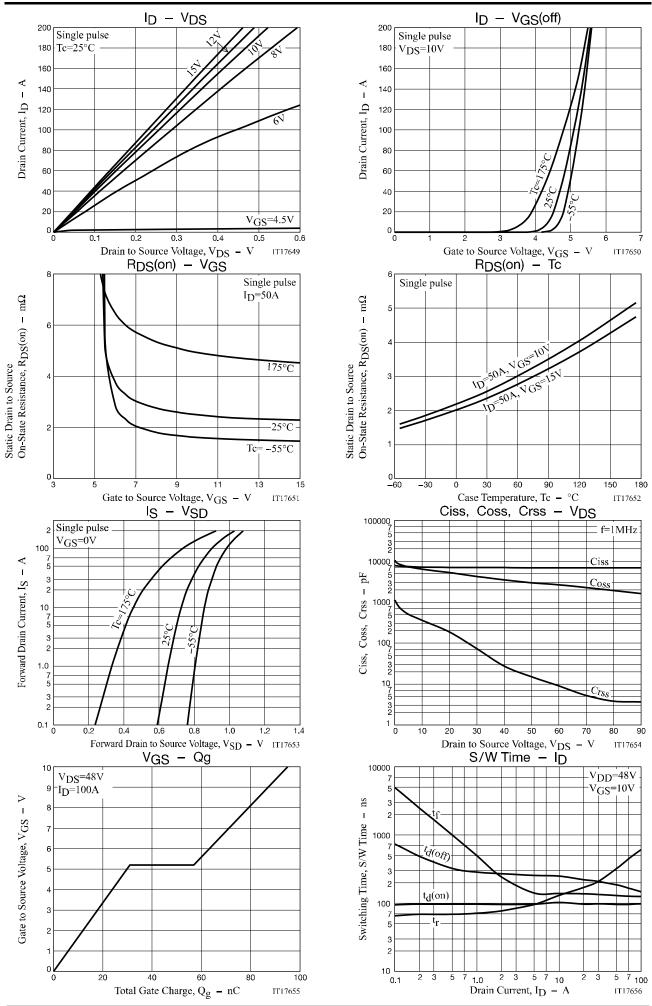
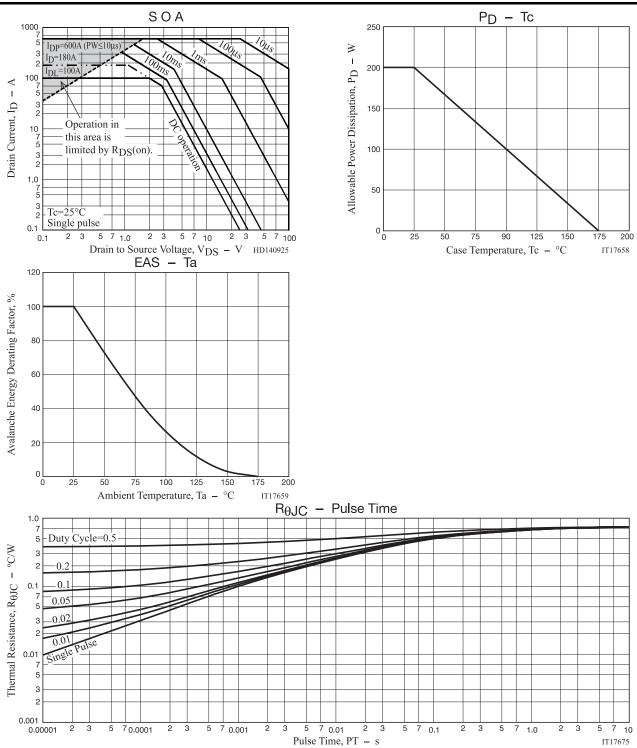


Fig.2 Switching Time Test Circuit





http://www.onsemi.com 3



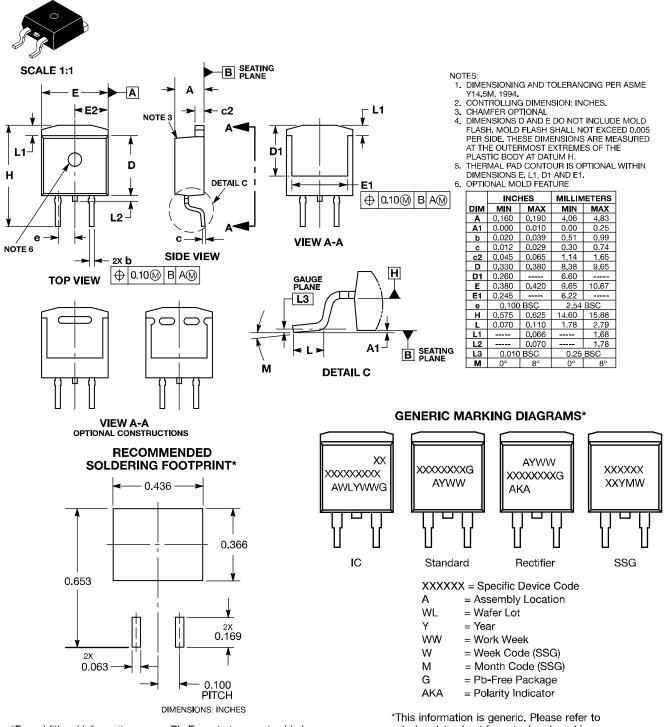
Package Dimensions

NDBA180N10BT4H

D²PAK-3 (TO-263, 3-LEAD)

CASE 418AJ ISSUE B

unit : mm



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "•", may or may not be present.

ORDERING INFORMATION

Device	ce Package Shipping		Note				
NDBA180N10BT4H	TO-263	800 pcs. / reel	Pb-Free and Halogen Free				

Note on usage : Since the NDBA180N10B is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

ON Semiconductor and the ON logo are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typical" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the desig